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(PTO-1449)




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EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	
		YI. Tang et al., "IMPROVEMENT AND ANALYSIS OF IMPLANTED-EMITTER BIPOLAR JUNCTION TRANSISTORS IN 4H-SiC", Materials Science Forum Vols. 389-393 (2002), pp. 1329-1332	
			

EXAMINER

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.